

1 ***In-situ* crystal structure determination of seifertite SiO₂ at 129 GPa: studying a**
2 **minor phase near Earth's core–mantle boundary**

3

4 Li Zhang^{1,*}, Dmitry Popov², Yue Meng², Junyue Wang^{1,3}, Cheng Ji^{1,4}, Bing Li^{1,4}, Ho-
5 kwang Mao^{1,3}

6

7 ¹Center for High Pressure Science and Technology Advanced Research (HPSTAR),
8 Shanghai 201203, China;

9 ²High Pressure Collaborative Access Team (HPCAT), Geophysical Laboratory,
10 Carnegie Institution of Washington, Argonne, IL 60439;

11 ³Geophysical Laboratory, Carnegie Institution of Washington, Washington, DC
12 20015;

13 ⁴High Pressure Synergetic Consortium (HPSynC), Geophysical Laboratory, Carnegie
14 Institution of Washington, Argonne, IL 60439;

15

16 *zhangli@hpstar.ac.cn

17

18 Seifertite SiO₂ likely exists as a minor phase near the core–mantle boundary.
19 Simulating the pressure and temperature conditions near the core–mantle boundary,
20 seifertite was synthesized as a minor phase in a coarse-grained, polycrystalline sample
21 coexisting with the (Mg,Fe)SiO₃ post-perovskite phase at 129 GPa and 2500 K. Here
22 we report the first *in-situ* single-crystal structure determination and refinement of
23 seifertite at high pressure and after a temperature quench from laser heating. We
24 improved the data coverage of a minor phase from a diamond anvil cell by merging
25 single-crystal data of seifertite from six selected grains which had different
26 orientations. Observed systematic absences of reflections from the six individual
27 grains allowed only one space group: *Pbcn*. The refined results of seifertite are in
28 good agreement with the predictions from previous first-principles calculations at
29 high pressure. This approach provides a method of structure determination of a minor
30 phase in a mineral assemblage synthesized under *P-T* conditions representative of the
31 deep Earth.

32 **Key words:** high pressure; crystal structure; multigrain; SiO₂; seifertite; synchrotron
33 X-ray; deep mantle

34

35 Earth's core–mantle boundary (CMB) is located at approximately 2900 km
36 beneath the surface, corresponding to pressures (P) of 136 GPa and temperatures (T)
37 greater than 2500 K. The major lower-mantle phase, iron-bearing magnesium silicate
38 (Mg,Fe)SiO₃ perovskite, transforms to a different, compact orthorhombic post-
39 perovskite (pPv) phase at P - T conditions near the CMB (Murakami et al., 2004;
40 Oganov and Ono, 2004), providing a possible explanation for the distinct seismic
41 features in the D'' layer above the CMB. SiO₂ is a common mineral in the Earth's
42 crust, and silicates comprise most of the mantle. Free SiO₂ may also exist in the
43 mantle through subduction of mid-ocean ridge basalt (MORB) crust (Andraut et al.,
44 2014; Hirose et al., 2005). Under pressure (P) and temperature (T) conditions relevant
45 to the Earth's lower mantle, SiO₂ transforms from stishovite to CaCl₂-type at ~50 GPa
46 and room temperature (Cohen, 1992; Kingma et al., 1994), then to α -PbO₂ like
47 structure known as seifertite (EL Goresy et al., 2008) at P - T conditions near the CMB
48 (Dubrovinsky et al., 1997; Grocholski et al., 2013). Knowing the accurate crystal
49 structure of seifertite at relevant P - T conditions is fundamentally important for
50 understanding the deep mantle.

51 The space group of seifertite has been under debate due to the similarity of the
52 systematic absences of several space groups (Belonoshko et al., 1996; Dera et al.,
53 2002; Dubrovinsky et al., 1997; Karki et al., 1997a; Karki et al., 1997b; Teter et al.,
54 1998; Tse et al., 1992; Tsuchida and Yagi, 1990). When the phase was first
55 experimentally discovered in a DAC (Dubrovinsky et al., 1997), the few peaks
56 observed in the powder XRD pattern did not allow unambiguous structure
57 determination, and thus the study assumed the theoretical predication of space group
58 $Pnc2$ (Belonoshko et al., 1996). A post-stishovite phase of SiO₂ was also discovered
59 in the Shergotty Meteorite (Sharp et al., 1999), and the powder X-ray diffraction

60 (XRD) data of this meteorite sample suggested the space group *Pbcn*. (Dera et al.,
61 2002). However, the study also pointed out that the power XRD pattern alone could
62 not unambiguously conclude the centrosymmetric structure (Dera et al., 2002). Later
63 first principles calculations came to agreement on the space group *Pbcn* (Karki et al.,
64 1997a; Karki et al., 1997b; Teter et al., 1998). Recent powder diffraction data provide
65 further constraints on the phase boundary between the CaCl_2 and $\alpha\text{-PbO}_2$ like phases
66 of SiO_2 and their equations of state up to 152 GPa and 3500 K in a laser-heated DAC
67 using noble gas media (Grocholski et al., 2013). To date, however, an unambiguous
68 structure determination of seifertite within its stability field has not yet been achieved,
69 due to the challenges in structure studies at ultrahigh pressure. Seifertite appears as a
70 minor phase in the run product at *P-T* conditions representative of the CMB when
71 MORB or Fe-rich orthopyroxene are used as the starting material, and such sample
72 environments may influence the crystal chemistry of seifertite (Hirose et al., 2005). In
73 this study, seifertite was also synthesized as a minor phase in a coarse-grained
74 polycrystalline mineral assemblage coexisting with $(\text{Mg,Fe})\text{SiO}_3$ pPv. We then
75 applied the multigrain approach (Sørensen et al., 2012) to obtain the first single-
76 crystal structure determination and unambiguous refinement of seifertite under
77 conditions representative of the CMB.

78

79 **Structure determination of a minor phase in a multiphase assemblage**

80 Powder X-ray diffraction (XRD) in a DAC has intrinsic limitations when the
81 sample consists of multiple phases with low symmetries. For instance, the natural
82 MORB sample decomposed to four phases at *P-T* condition representative of the
83 CMB: MgSiO_3 -rich pPv, $\alpha\text{-PbO}_2$ -type SiO_2 , Ca-perovskite and CaFe_2O_4 -type Al-
84 phase (Hirose et al., 2005). Overlapping peaks in such a powder XRD pattern make

85 phase indexation and structure determination challenging in high-pressure
86 mineralogical studies. On the other hand, single-crystal XRD provides a more
87 definitive characterization of a crystal structure at high pressure. To achieve good
88 reciprocal space coverage from a single-crystal in a DAC, efforts have been made to
89 maximize the DAC opening while still maintaining high pressure. For instance, an X-
90 ray aperture of 85° was achieved at pressure up to 50 GPa for this purpose (Boehler,
91 2006). Still, maintaining such a wide X-ray access angle becomes challenging at
92 higher pressure. Even in a successful single-crystal DAC experiment, only a portion
93 of the reciprocal space can be illuminated by X-rays (Miletich et al., 2000).
94 Meanwhile, a single pre-selected crystal (or several) can only be maintained in a soft
95 pressure-transmitting medium of He or Ne to a certain pressure. At elevated pressures,
96 preloaded single crystals either become degraded or break into polycrystallites when
97 passing through a phase transition. In high-pressure petrological studies, multiple
98 phases coexist in a polycrystalline sample as a result of phase equilibrium, and the
99 structure determination and crystal chemistry of each phase is fundamentally
100 important for understanding the phase relations in such system. However, new
101 structures and minor phases are often overshadowed by the diffraction of major
102 phases in a powder diffraction pattern, and are impossible to identify. Therefore, the
103 structure determination of a minor phase in such a multiphase assemblage has never
104 previously been possible using conventional single-crystal or powder diffraction
105 techniques.

106 Utilization of the multigrain method (Sørensen et al., 2012) for a polycrystalline
107 sample in a DAC has opened a new area for high-pressure crystallography at megabar
108 pressures (Nisar et al., 2012; Zhang et al., 2013). The multigrain approach also allows
109 the separation of crystallographic information of an unknown phase from a mixture at

110 high pressure (Zhang et al., 2014). As the X-ray beams available at synchrotron
111 facilities tend to be very focused and intense, most of the powder XRD patterns will
112 show some degree of spottiness. Heating a powder sample can further promote
113 spottiness in a powder XRD pattern due to crystal growth at high temperature.
114 Spottiness, which is generally considered as a flaw in a powder XRD, can be turned
115 into great advantage if we can handle the diffraction patterns from many individual
116 crystallites as if they were from isolated single crystals. While successful
117 demonstration for crystal structure refinement in a polycrystalline sample at ambient
118 conditions using the multigrain approach (Schmidt et al., 2003; Vaughan et al., 2004),
119 an ideal single-crystal can often be obtained at ambient conditions for the use of
120 conventional single-crystal techniques. On the other hand, the multigrain approach
121 shows great advantages for *in-situ* studying a polycrystalline sample at high pressure
122 by determining an individual orientation matrix for each individual grain, allowing
123 high-pressure crystallographic studies unachievable using conventional single crystal
124 techniques. In this study, we demonstrate a solution for structure determination of a
125 minor phase within a multiple phase assemblage at high pressures representative of
126 the CMB.

127 **Synthesis of seifertite as minor phase and its unit cell parameters**

128 In this study, an orthopyroxene sample with $(\text{Mg}_{0.6}\text{Fe}_{0.4})\text{SiO}_3$ composition and
129 ~5% excess of SiO_2 was used as the starting material. The starting material was pre-
130 compressed into disks of ~10 μm thickness and cut to ~40 μm in diameter and placed
131 in a rhenium (Re) gasket hole in a Mao-type symmetric DAC filled with Ne. Diamond
132 anvils with flat culet diameters of 120 μm beveled at 10° up to 300 μm were mounted
133 in Bohler seats with up to 60° X-ray opening. The micro-focused x-ray diffraction
134 with *in-situ* laser heating available at 16IDB at the Advanced Photon Source (APS) of

135 Argonne was used to study changes in the sample at P - T conditions representative of
136 the CMB. Temperatures were measured on both sides by spectroradiometry (Shen et
137 al., 2001) and pressures were determined from the unit-cell volumes of Ne (Fei et al.,
138 2007) after T quench from laser heating.

139 Free silica crystallized in seiferite as a minor phase above 118 GPa and 2500 K,
140 but remained as CaCl_2 -type structure at 111 GPa and 2500 K, suggesting a narrow
141 depth for the existence of seifertite in the lowermost mantle. This result is consistent
142 with the most recent study in which SiO_2 was mixed with a metal absorber
143 (Grocholski et al., 2013). The coarse-grained polycrystallites of seifertite were
144 obtained in a quasihydrostatic environment of Ne after laser heating, and showed
145 highly spotty XRD patterns within the 5–8 μm focused X-ray microbeam.

146 Seifertite was again synthesized at 129 GPa and 2500 K in a DAC that offers a
147 opening angle of $4\theta > 50^\circ$. The unit-cell parameter of Ne after T quench was 2.903(8)
148 Å calculated from four diffraction lines 111, 200, 220 and 311. Figure 2(A) and 2(B)
149 show seifertite as a minor phase coexisting with pPv and the characteristic peak 110 at
150 2.90 Å and 111 at 2.39 Å were identified for seifertite. Over 40,000 diffraction spots
151 were obtained from the XRD patterns collected by rotating the DAC from -24° to 24°
152 at steps of 0.2° . Such a small angular step was used in order to improve the signal-to-
153 noise ratio by reducing the background level. The exposure time was 20 sec/frame.
154 The FABLE package (Sørensen et al., 2012) was used to filter the spots, and
155 GrainSpotter (Schmidt, 2014) in the package was used to assign the reflections to
156 each of the specific orientation matrices. Over one hundred grains were identified, but
157 most are too fine for structure analysis. Only those with maximum number of
158 reflections were selected for further structure studies.

159 Multigrain patterns show great advantages for separating reflections with close
160 d -spacings and picking up weak reflections when compared to powder XRD patterns
161 with smooth rings. Figure 3 shows three pairs of diffraction reflections from one
162 selected grain of seifertite. In a 2D powder XRD pattern, the {302} diffraction ring
163 with d -spacing of 1.067 Å would overlap with {321} with 1.061 Å; in a multigrain
164 pattern, however, each of the reflections can be unambiguously identified through its
165 unique rotation, Bragg and azimuth angles, as shown in Figure 3(A) and 3(B).
166 Additionally, weak diffraction peaks are often overshadowed by the background noise
167 in a smooth powder XRD pattern; in contrast, a couple of diffraction spots contribute
168 to most of the intensity of a diffraction peak in a multigrain pattern, and, therefore,
169 weak reflections, such as the {421} reflections shown in Figure 3(C), can be picked
170 out, despite having only a few pixels slightly more intense than the background.

171 In the powder pattern most peaks at high d -spacing were overshadowed by the
172 strong peaks from the major phase pPv (Figure 2(B)), only one characteristic peak of
173 seifertite (2.90 Å) was observed in the low d -spacing region. On the other hand, the
174 multigrain approach allows us to calculate the unit-cell parameters from multiple
175 grains through three-dimensional orientation and geometrical relationships. Table 1
176 shows the calculated unit-cell parameters from four individual grains and merged
177 grains using the software UNITCELL (Holland and Redfern, 1997). The unit cell
178 parameters of seifertite at 129 GPa are: $a=3.7277(2)$ Å, $b=4.6576(2)$ Å, $c=4.1609(3)$
179 Å, $V=72.243(5)$ Å³. The standard deviations for the calculated unit-cell parameters are
180 found to be nearly inversely proportional to the square root of the number of
181 reflections, demonstrating our measurements statistically robust. The uncertainties in
182 d -values are mainly defined by resolution of the monochromator. The unit-cell
183 volume obtained in this study is 1.1% higher than the volume from previous powder

184 XRD data at 129 GPa (Grocholski et al., 2013), corresponding to a pressure difference
185 of ~6 GPa, likely due to the difference between the Au and Ne pressure scales. The
186 *a/b* and *a/c* ratios are in reasonable agreement with our results because the ratios are
187 not pressure sensitive due to the compact configuration of the seiferite structure. The
188 *a/b* and *a/c* ratios from another powder XRD study (Murakami, 2003) are 3.7 and
189 1.0% lower than the values obtained from our study, respectively, probably due to the
190 non-hydrostatic environment in the previous study. In comparison with powder
191 diffraction, the multigrain approach provides a solution for accurate calculations of
192 unit-cell parameters, especially for a minor phase in a mineral assemblage where
193 multiple phases coexist.

194 **Structure determination and refinement of seifertite**

195 Intensities of reflections from each selected grain have been calculated using
196 the XDS software (Kabsch, 2010). This program uses very efficient integration and
197 scaling algorithms, but it assumes that reflections from only one crystal are present on
198 X-ray images. That was why, among all the diffraction spots identified by XDS, only
199 those from a selected crystalline grain had to be selected. For this purpose a pair of
200 reflections from this grain was previously identified using the FABLE package.
201 Indices and coordinates of these two reflections were used to calculate the orientation
202 matrix (Busing and Levy, 1967) which in turn allowed us to identify all the reflections
203 belonging to this grain. Some specifically developed software was implemented for
204 this purpose. All further data processing by XDS was done as normal, assuming there
205 was only one crystal in the beam. XDS does not allow the definition of shaded areas
206 changing during the data collection routine. That was why reflections shaded by the
207 DAC were recognized by XDS as having intensities below the detectable level. Such
208 reflections have been removed, by another program we developed, from the output

209 listings after the integration, based on the orientation and opening of the DAC.
210 Calibration of sample-to-detector distance and detector tilt was done based on a
211 diffraction pattern from CeO₂ powder standard using Fit2d software (Hammersley et
212 al., 1996). CrysAlis (Oxford Diffraction Ltd, 2006) and other softwares may also be
213 used for integration and scaling purpose and considered for future.

214 As the available number of reflections from a single-crystal was limited by its
215 DAC opening, data from six individual grains with the maximum number of available
216 reflections have been used to determine the space group of seifertite at 129 GPa.
217 Observed systematically absent reflections allowed only space group: *Pbcn* (#60),
218 confirming the prediction by theory (Karki et al., 1997a; Karki et al., 1997b; Teter et
219 al., 1998). The same six grains were selected for structure solution and refinement.
220 Pole figures shown in Figure 1 represent the random crystallographic orientations of
221 six selected grains. Compatibility between these six data sets has been checked by
222 merging them using the XSCALE software available within the XDS package. In total
223 613 reflections have been combined providing a redundancy of 6.6. Ten misfits due to
224 overlap of reflections from different grains, overlap with diamond peaks, or locations
225 close to shaded areas have been rejected by XDS automatically. Data completeness of
226 92.1% was achieved in the *d*-spacing range down to 0.72Å, approaching nearly full
227 access to a reflection sphere of the structure. The position of Si was determined from
228 a Patterson map, and coordinates of O were obtained from a difference in electron
229 density map calculated after refinement of the Si atomic position. The refinement of
230 the structure was performed against the resulting intensity data of 81 independent
231 reflections using anisotropic thermal parameters. Ten independent reflections were
232 not included into the refinement, but used to calculate R_{free} value which was not
233 affected by overfitting. A reasonable R_{free} =6.4% was obtained. Four misfits have been

234 rejected from the refinement process. Some more misfits still may be present in the
235 data set; however, their influence on the R-factor is probably reduced due to
236 averaging with the majority of the reflections. All the calculations were performed
237 using the SHELX package (Sheldrick, 2008). Atomic coordinates refined against all
238 these data sets are given in Table 2, while crystallographic data, parameters of the
239 structure refinements, and interatomic distances are given in Table 3 and are
240 compared to the structure data from previous theoretical calculations at high pressure
241 (Karki et al., 1997a; Karki et al., 1997b; Teter et al., 1998) and to the powder XRD
242 data of the meteorite sample at ambient conditions (Dera et al., 2002). The refined
243 structure results at 129 GPa are in good agreement with previous theoretical
244 calculations at 120 GPa (Karki et al., 1997a; Karki et al., 1997b; Teter et al., 1998).
245 However, when structures become more complicated, theory and experiment may
246 show different strengths: as theoretical calculations can reach any pressure range,
247 while experimental approaches may better handle complicated chemistry.

248 **Implications**

249 The space group *Pbcn* (#60) of seifertite was unambiguously determined based
250 solely on the observed systematically absences of reflections from six differently
251 orientated grains, solving the long-standing controversy. Compared with the structure
252 of seifertite at ambient conditions in a powder meteorite sample (Dera et al., 2002),
253 we found that compression of seifertite is nearly isotropic over the megabar pressure
254 range with $a/c=0.91$ and $b/c=1.12$, a property distinct from that of low-pressure
255 polymorphs of SiO₂, such as quartz (Angel et al., 1997) and stishovite (Andrault et al.,
256 2003; Grocholski et al., 2013). The compact configuration of seifertite, especially the
257 short distance between the neighboring unoccupied octahedral voids (Dera et al.,
258 2002), may contribute to such behavior.

259 Additionally, the unit-cell parameters of seifertite can be precisely determined
260 from hundreds of reflections in a multigrain sample, despite being a minor phase in a
261 mineral assemblage above megabar pressure. Therefore, SiO₂ may serve as a pressure
262 scale in an Fe-bearing sample environment, because other commonly used pressure
263 scales, such as MgO and Pt, often react with Fe-bearing components, especially in
264 high-temperature experiments with heating. However, Al₂O₃ can be incorporated into
265 the seifertite (Grocholski et al., 2013; Hirose et al., 2005), suggesting SiO₂ would not
266 be an ideal pressure scale in Al-bearing compositions.

267 In this study, the FABLE and XDS packages were bridged in order to determine
268 the structure of a minor phase in a polycrystalline mineral assemblage contained in a
269 DAC. This study demonstrates that the multigrain approach (Sørensen et al., 2012)
270 can be applied to tough data collections for studying phase transitions, crystal
271 chemistry, and chemical reactions in a petrological multiphase system under *P-T*
272 conditions representative of the deep Earth.

273

274 **ACKNOWLEDGMENTS**

275 We thank J. Smith and S. Sinogeikin for their technical support and G. Shen, S.
276 Schmidt, S. Merkel and A. Katrusiak for their helpful discussions. L. Zhang
277 acknowledges HPSTAR and the Foundation of President of China Academy of
278 Engineering Physics (Grant No: 201402032). The experiment was performed at
279 HPCAT (Sector 16), Advanced Photon Source (APS), Argonne National Laboratory.
280 HPCAT operations are supported by the U.S. Department of Energy–National
281 Nuclear Security Administration (DOE-NNSA) under award DE-NA0001974 and
282 DOE–Basic Energy Sciences (BES) under award DE-FG02-99ER45775, with partial

283 instrumentation funding by NSF. Use of the APS facility was supported by DOE-BES
284 under contract DE-AC02-06CH11357.
285

286 **REFERENCES CITED:**

- 287 Andrault, D., Angel, R.J., Mosenfelder, J.L., and Le Bihan, T. (2003) Equation of
288 state of stishovite to lower mantle pressures. *American Mineralogist*, 88,
289 301-307.
- 290 Andrault, D., Pesce, G., Bouhifd, M.A., Bolfan-Casanova, N., Henot, J.M., and
291 Mezouar, M. (2014) Melting of subducted basalt at the core-mantle
292 boundary. *Science*, 344(6186), 892-5.
- 293 Angel, R.J., Allan, D.R., Miletich, R., and Finger, L.W. (1997) The Use of Quartz as
294 an Internal Pressure Standard in High-Pressure Crystallography. *Journal*
295 *of Applied Crystallography*, 30, 461-466.
- 296 Belonoshko, A.B., Dubrovinsky, L.S., and Dubrovinsky, N.A. (1996) A new high-
297 pressure silica phase obtained by molecular dynamics. *American*
298 *Mineralogist*, 81, 785-788.
- 299 Boehler, R. (2006) New diamond cell for single-crystal x-ray diffraction. *Review*
300 *of Scientific Instruments*, 77(11), 115103.
- 301 Busing, W.R., and Levy, H.A. (1967) Angle Calculations for 3- and 4- Circle X-ray
302 and Neutron Diffractometers. *Acta Crystallographica*, 22, 457-464.
- 303 Cohen, R.E. (1992) First-Principles Predictions of Elasticity and Phase
304 Transitions in High Pressure SiO₂ and Geophysical Implications. In Y.
305 Syono, and M.H. Manghnani, Eds. *High-Pressure Research: Application to*
306 *Earth and Planetary Sciences*. American Geophysical Union, Washington,
307 D. C.
- 308 Dera, P., Prewitt, C.T., Boctor, N.Z., and Hemley, R.J. (2002) Characterization of a
309 high-pressure phase of silica from the Martian meteorite Shergotty.
310 *American Mineralogist*, 87, 1018-1023.
- 311 Dubrovinsky, L.S., Saxena, S.K., Lazor, P., Ahuja, R., Eriksson, O., Wills, J.M., and
312 Johansson, B. (1997) Experimental and theoretical identification of a
313 new high pressure phase of silica. *Nature*, 388, 362-365.
- 314 EL Goresy, A., Dera, P., Sharp, T.G., Prewitt, C.T., Chen, M., Dubrovinsky, L.,
315 Wopenka, B., Boctor, N.Z., and Hemley, R.J. (2008) Seifertite, a dense
316 orthorhombic polymorph of silica from the Martian meteorites Shergotty
317 and Zagami. *European Journal of Mineralogy*, 20, 523-528.
- 318 Fei, Y., Ricolleau, A., Frank, M., Mibe, K., Shen, G., and Prakapenka, V. (2007)
319 Toward an internally consistent pressure scale. *Proc Natl Acad Sci U S A*,
320 104(22), 9182-6.
- 321 Grocholski, B., Shim, S.H., and Prakapenka, V.B. (2013) Stability, metastability,
322 and elastic properties of a dense silica polymorph, seifertite. *Journal of*
323 *Geophysical Research: Solid Earth*, 118(9), 4745-4757.
- 324 Hammersley, A.P., Svensson, S.O., Hanfland, M., Fitch, A.N., and Hausermann, D.
325 (1996) Two-dimensional detector software: from real detector to
326 idealised image or two-theta scan. *High Pressure Research*, 14(4-6), 235-
327 248.
- 328 Hirose, K., Takafuji, N., Sata, N., and Ohishi, Y. (2005) Phase transition and
329 density of subducted MORB crust in the lower mantle. *Earth and*
330 *Planetary Science Letters*, 237(1-2), 239-251.
- 331 Holland, T.J.B., and Redfern, S.A.T. (1997) UNIT CELL refinement from powder
332 diffraction data: the use of regression diagnostics. *Mineralogical*
333 *Magazine*, 61, 65-77.

- 334 Kabsch, W. (2010) Xds. *Acta Crystallogr D Biol Crystallogr*, 66(Pt 2), 125-32.
335 Karki, B.B., Warren, M.C., Stixrude, L., Ackland, G.J., and Crain, J. (1997a) Ab initio
336 studies of high-pressure structural transformations in silica. *Physical*
337 *Review B*, 55(6), 3465-3471.
338 -. (1997b) Erratum: Ab initio studies of high-pressure structural transformations
339 in silica. *Physical Review B*, 56(5), 2884.
340 Kingma, K.J., Cohen, R.E., Hemley, R.J., and Mao, H.-K. (1994) Transformation of
341 stishovite to a denser phase at lower-mantle pressures. *Nature*, 374, 243-
342 245.
343 Miletich, R., Allan, D.R., and Kuhs, W.F. (2000) High-Pressure Single-Crystal
344 Techniques. *Reviews in Mineralogy and Geochemistry*, 41(1), 445-519.
345 Murakami, M. (2003) Stability of CaCl₂-type and α -PbO₂-type SiO₂ at high
346 pressure and temperature determined by in-situ X-ray measurements.
347 *Geophysical Research Letters*, 30(5).
348 Murakami, M., Hirose, K., Kawamura, K., Sata, N., and Ohishi, Y. (2004) Post-
349 perovskite phase transition in MgSiO₃. *Science*, 304(5672), 855-8.
350 Nisr, C., Ribárik, G., Ungár, T., Vaughan, G.B.M., Cordier, P., and Merkel, S. (2012)
351 High resolution three-dimensional X-ray diffraction study of dislocations
352 in grains of MgGeO₃ post-perovskite at 90 GPa. *Journal of Geophysical*
353 *Research: Solid Earth*, 117(B3), B03201.
354 Oganov, A.R., and Ono, S. (2004) Theoretical and experimental evidence for a
355 post-perovskite phase of MgSiO₃ in Earth's D" layer. *Nature*, 430, 445-
356 448.
357 Oxford Diffraction Ltd. (2006) CrysAlis Red.
358 Schmidt, S. (2014) GrainSpotter: a fast and robust polycrystalline indexing
359 algorithm. *Journal of Applied Crystallography*, 47(1), 276-284.
360 Schmidt, S., Poulsen, H.F., and Vaughan, G.B.M. (2003) Structural refinements
361 of the individual grains within polycrystals and powders. *Journal of*
362 *Applied Crystallography*, 36, 326-332.
363 Sharp, T.G., El Goresy, A., Wopenka, B., and Chen, M. (1999) A Post-Stishovite
364 SiO₂ Polymorph in the Meteorite Shergotty: Implications for Impact
365 Events. *Science*, 284, 1511-1513.
366 Sheldrick, G.M. (2008) A short history of SHELX. *Acta Crystallogr A*, 64(Pt 1),
367 112-22.
368 Shen, G., Rivers, M.L., Wang, Y., and Sutton, S.R. (2001) Laser heated diamond cell
369 system at the Advanced Photon Source for in situ x-ray measurements at
370 high pressure and temperature. *Review of Scientific Instruments*, 72(2),
371 1273-1282.
372 Sørensen, H.O., Schmidt, S., Wright, J.P., Vaughan, G.B.M., Techert, S., Garman, E.F.,
373 Oddershede, J., Davaasambu, J., Paithankar, K.S., Gundlach, C., and
374 Poulsen, H.F. (2012) Multigrain crystallography. *Zeitschrift für*
375 *Kristallographie*, 227(1), 63-78.
376 Teter, D.M., Hemley, R.J., Kresse, G., and Hafner, J. (1998) High Pressure
377 Polymorphism in Silica. *Physical Review Letters*, 80(10), 2145-2148.
378 Tse, J., Klug, D., and Le Page, Y. (1992) Novel high pressure phase of silica.
379 *Physical Review Letters*, 69(25), 3647-3649.
380 Tsuchida, Y., and Yagi, T. (1990) New pressure-induced transformations of silica
381 at room temperature. *Nature*, 347, 267-269.

- 382 Vaughan, G.B.M., Schmidt, S., and Poulsen, H.F. (2004) Multicrystal approach to
383 crystal structure solution and refinement. *Zeitschrift für Kristallographie*,
384 219, 813-825.
- 385 Zhang, L., Meng, Y., Dera, P., Yang, W., Mao, W.L., and Mao, H.K. (2013) Single-
386 crystal structure determination of (Mg,Fe)SiO₃ postperovskite. *Proc Natl*
387 *Acad Sci U S A*, 110(16), 6292-5.
- 388 Zhang, L., Meng, Y., Yang, W., Wang, L., Mao, W.L., Zeng, Q.S., Jeong, J.S., Wagner,
389 A.J., Mkhoyan, K.A., Liu, W., Xu, R., and Mao, H.K. (2014)
390 Disproportionation of (Mg,Fe)SiO₃ perovskite in Earth's deep lower
391 mantle. *Science*, 344(6186), 877-82.
- 392

393 **List of figure captions:**

394 **Figure 1.** 100, 010 and 001 pole figures, representing the random orientations of six
395 selected grains of seifertite for structure refinement. Compression axis in the DAC is
396 along x_s and the sample was confined in a Re gasket along y_s and z_s .

397

398 **Figure 2.** XRD data of seifertite at 129 GPa and after T quench: (A) A representative
399 spotty XRD pattern of seifertite coexisting with the dominant phase pPv at a fixed
400 rotation angle (x-ray wavelength of 0.3738 Å), S-silica, pPv-post-perovskite, Ne-neon;
401 (B) An integrated powder pattern at a fixed omega angle showing the intensity
402 contrast between the major phase (Mg,Fe)SiO₃-pPv and seifertite (X-ray wavelength:
403 0.3738 Å). The characteristic peak 110 at 2.90 Å for seifertite is several times weaker
404 than the major peaks from coexisting pPv.

405

406 **Figure 3.** Selected diffraction reflections from one grain of seifertite are shown in the
407 middle within 30 by 30 pixels (pixel size: 79 μm) at 129 GPa: (A-B) the multigrain
408 method distinguishes a pair of {302} reflections from another pair of {321} with close
409 d -spacing; (C) a pair of weak {421} reflections with only a few pixels slightly more
410 intense than the background can be picked out by the multigrain method.

411 **Table 1.** Calculated unit-cell parameters from multiple grains of seifertite at 129 GPa
412 and room T .

Parameters	Grain1	Grain2	Grain3	Grain4	Grain1+2	Grain1+2+3	Grain1+2+3+4
a (Å)	3.72908	3.72933	3.72762	3.72537	3.72919	3.72862	3.72774
$\sigma(a)$	0.00040	0.00030	0.00027	0.00027	0.00024	0.00018	0.00015
b (Å)	4.65973	4.65857	4.65534	4.65754	4.65927	4.65765	4.65760
$\sigma(b)$	0.00051	0.00060	0.00045	0.00054	0.00039	0.00027	0.00024
c (Å)	4.16033	4.15955	4.16708	4.16019	4.15994	4.16076	4.16090
$\sigma(c)$	0.00048	0.00049	0.00169	0.00083	0.00034	0.00033	0.00030
V (Å ³)	72.2920	72.2653	72.3127	72.1839	72.2803	72.2583	72.2429
$\sigma(V)$	0.0087	0.0095	0.0245	0.0106	0.0063	0.0055	0.0047
N (reflections)	48	48	50	47	96	146	193

413

414

415

416

417

418

419

420

421

422 **Table 2.** Fractional coordinates of atoms and their isotropic thermal parameters.

423

Atom	x	y	z	Ueq
Si	0.0000	0.1504(3)	0.2500	0.0067(7)
O	0.7418(4)	0.6130(3)	0.919(1)	0.0069(8)

424

425 **Table 3.** Crystallographic data, parameters of structure refinements and interatomic
 426 distances in comparison with previous studies.

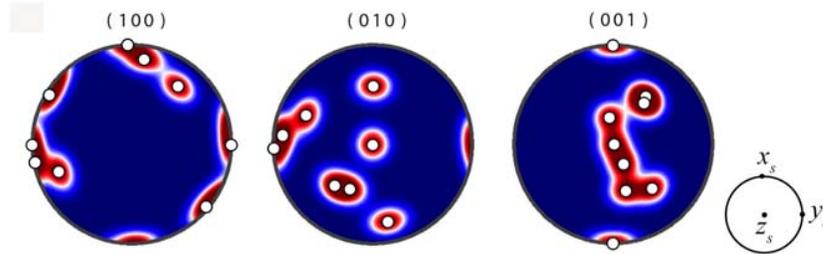
Parameters	Multigrain This study	Theory Teter et al. (1998)	Theory Karki et al. (1997a, b)	Powder Dera et al. (2002)
P, GPa	129 GPa	120 GPa	120 GPa	0 GPa
a, Å	3.7277(2)	3.711	/	4.097(1)
b, Å	4.6576(2)	4.651	/	5.0462(9)
c, Å	4.1609(3)	4.159	/	4.4946(8)
ySi	0.1504(3)	0.1502	0.1501	0.1522(9)
xO	0.7418(4)	0.7424	0.7423	0.7336(19)
yO	0.6130(3)	0.6130	0.6134	0.6245(12)
zO	0.919(1)	0.9201	0.9201	0.9186(29)
Measured/independent/ free reflections	609/81/10	/	/	/
Refined parameters	15	/	/	/
R/R _{free}	0.056/0.064	/	/	/
R _{int}	0.096	/	/	0.034
Completeness	92.1%	/	/	/
Redundancy	6.6	/	/	/
Si-O	1.624(2) ×2	1.621×2	/	1.735×2
Si-O	1.655(3) ×2	1.650×2	/	1.783×2
Si-O	1.677(2) ×2	1.676×2	/	1.861×2

427

428

429 **Figure 1.**

430

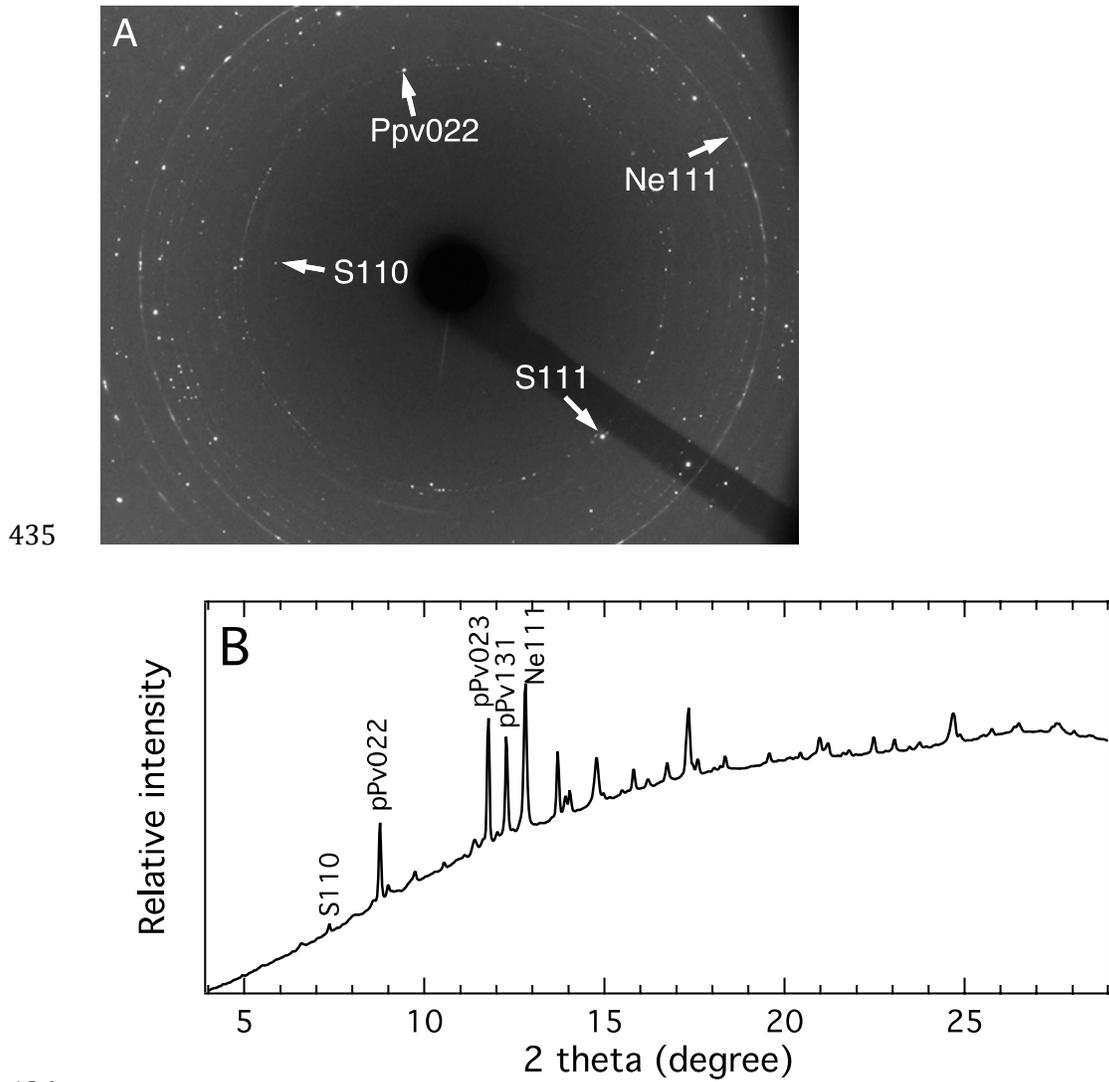


431

432

433

434 **Figure 2.**



436

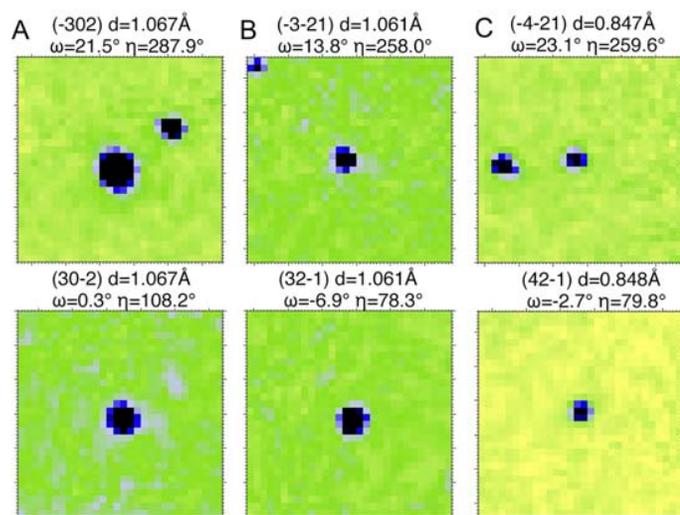
437

438

439

440 **Figure 3.**

441



442

443